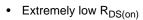


# P-Channel 30 V (D-S) MOSFET

PRODUC	PRODUCT SUMMARY				
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$ Max.	I <sub>D</sub> <sup>a</sup>	Q <sub>g</sub> (Typ.)		
	0.0078 at V <sub>GS</sub> = - 10 V	- 26			
- 30	0.0082 at V <sub>GS</sub> = - 6 V	- 23	66 nC		
	0.0092 at V <sub>GS</sub> = - 4.5 V	- 20			

#### **FEATURES**

 Extended V<sub>GS</sub> range (± 25 V) for adaptor switch applications

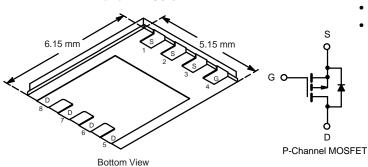


- TrenchFET® Power MOSFET
- 100 % R<sub>g</sub> and UIS Tested
- Typical ESD Performance: 4000 V (HBM)



ROHS COMPLIANT HALOGEN FREE

#### PowerPAK SO-8



### **APPLICATIONS**

- · Adaptor Switch, Load Switch
  - Power Management

    Notebook Computers and Portable
    Battery Packs

Parameter	Symbol	<b>Limit</b> - 30			
Drain-Source Voltage				V <sub>DS</sub>	
Gate-Source Voltage		V <sub>GS</sub>	± 25		
	T <sub>C</sub> = 25 °C		- 26		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>C</sub> = 70 °C	1-	- 20.7		
Continuous Drain Current (1) = 130 C)	T <sub>A</sub> = 25 °C	- I <sub>D</sub>	- 17.3		
	T <sub>A</sub> = 70 °C		- 13.9 <sup>b, c</sup>	Α	
Pulsed Drain Current (t = 300 µs)		I <sub>DM</sub>	- 60	^	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	la la	- 5.8 <sup>b, c</sup>		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	- I <sub>S</sub>	- 2.6 <sup>b, c</sup>		
Single Pulse Avalanche Current L = 0.1 mH		I <sub>AS</sub>	- 40		
Single Pulse Avalanche Energy		E <sub>AS</sub>	80	mJ	
	T <sub>C</sub> = 25 °C		6.9		
Maximum Dawar Dissination	T <sub>C</sub> = 70 °C	P <sub>D</sub>	4.4	W	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C		3.1 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		2 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	R <sub>thJA</sub>	33	40	°C/W
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	15	17	0/11

#### Notes:

- a. Based on  $T_C = 25$  °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c t = 10 s
- d. Maximum under steady state conditions is 90 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	,						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA	- 30			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$			- 24			
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = - 250 μA		6		mV/°0	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_{D} = -250 \mu A$	- 1.2		- 2.8	V	
	, ,	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			± 150		
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 15	- μΑ	
		V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V			- 1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 20			Α	
	,	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 13 A		0.0054	0.0078		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 6 V, I <sub>D</sub> = - 10 A		0.0068	0.0082	Ω	
Diani course on clate recipiance		V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 8 A		0.0083	0.0092		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 13 A		44		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			4620			
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		880		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			820			
Total Cata Chausa	0	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 17.3 A		102	153		
Total Gate Charge	$Q_g$			66	80		
Gate-Source Charge	$Q_{gs}$	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 5 V, I <sub>D</sub> = - 17.3 A		16		nC	
Gate-Drain Charge	$Q_{gd}$			28			
Gate Resistance	$R_g$	f = 1 MHz	0.3	1.3	2.6	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			70	105		
Rise Time	t <sub>r</sub>	$V_{DD} = 0 \text{ V}, R_L = 1.5 \Omega$		70	105		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 10 A, $V_{GEN}$ = - 4.5 V, $R_g$ = 1 $\Omega$		45	68		
Fall Time	t <sub>f</sub>			27	41		
Turn-On Delay Time	t <sub>d(on)</sub>			18	30	ns	
Rise Time	t <sub>r</sub>	$V_{DD} = -15 \text{ V}, R_{L} = 1.5 \Omega$		15	25		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 10 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 $\Omega$		52	80		
Fall Time	t <sub>f</sub>			14	25		
Drain-Source Body Diode Characteristic	s				L		
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 26	Λ	
Pulse Diode Forward Current	I <sub>SM</sub>				- 60	Α	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = - 10 A, V <sub>GS</sub> = 0 V		- 0.78	- 1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			35	53	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	1 40 A dl/dt 400 A/: T 05 00		25	38	nC	
Reverse Recovery Fall Time	ta	$I_F = -10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		19			
						ns	

#### Notes:

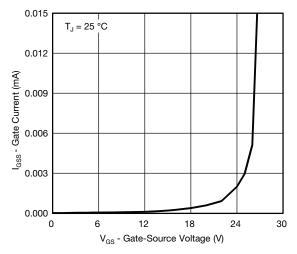
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%$ 

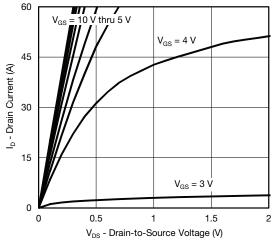
b. Guaranteed by design, not subject to production testing.



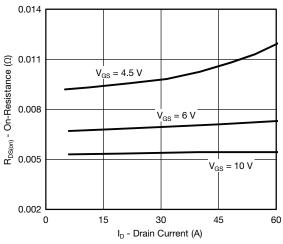
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



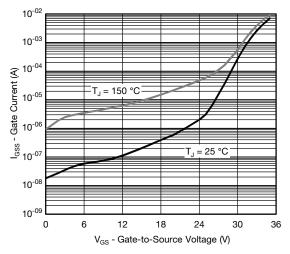
Gate Current vs. Gate-Source Voltage



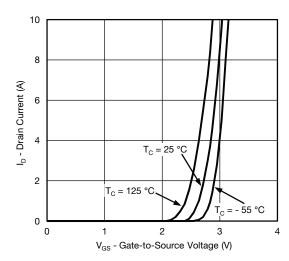
**Output Characteristics** 



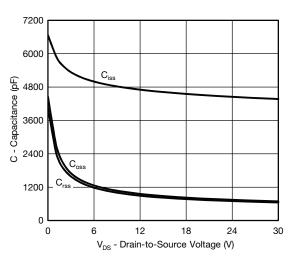
On-Resistance vs. Drain Current



Gate Current vs. Gate-Source Voltage



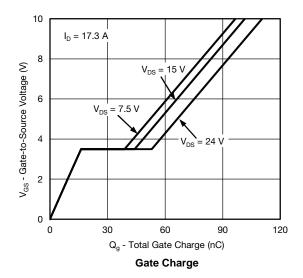
Transfer Characteristics

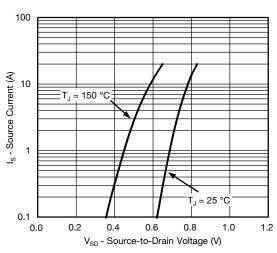


Capacitance

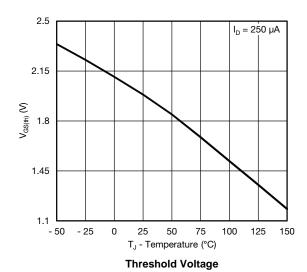


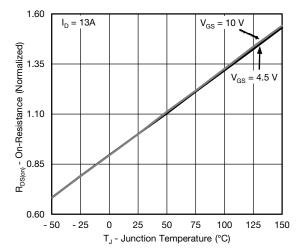
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



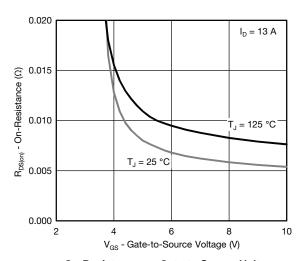


Source-Drain Diode Forward Voltage

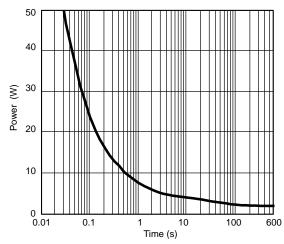




On-Resistance vs. Junction Temperature

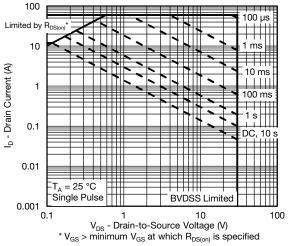


On-Resistance vs. Gate-to-Source Voltage

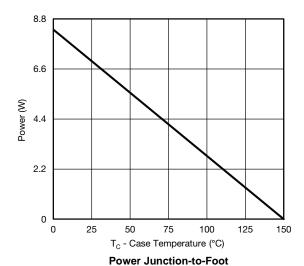


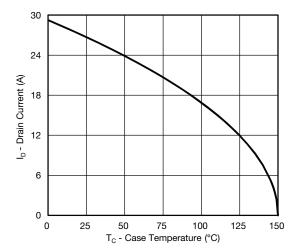
Single Pulse Power, Junction-to-Ambient

### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

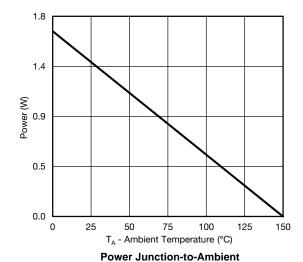








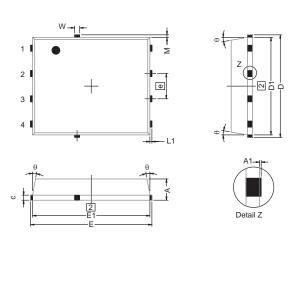


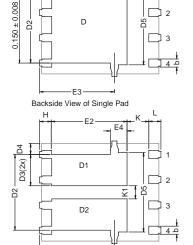


<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



# PowerPAK SO-8, (SINGLE/DUAL)





### Notes

- 1. Inch will govern.
- 2 Dimensions exclusive of mold gate burrs.
- 3. Dimensions exclusive of mold flash and cutting burrs.

	-E3	
Rackeide	View of D	ual Pad

	MILLIMETERS			INCHES		
DIM.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
Α	0.97	1.04	1.12	0.038	0.041	0.044
A1	0.00	-	0.05	0.000	=	0.002
b	0.33	0.41	0.51	0.013	0.016	0.020
С	0.23	0.28	0.33	0.009	0.011	0.013
D	5.05	5.15	5.26	0.199	0.203	0.207
D1	4.80	4.90	5.00	0.189	0.193	0.197
D2	3.56	3.76	3.91	0.140	0.148	0.154
D3	1.32	1.50	1.68	0.052	0.059	0.066
D4		0.57 TYP.		0.0225 TYP.		
D5		3.98 TYP.		0.157 TYP.		
Е	6.05	6.15	6.25	0.238	0.242	0.246
E1	5.79	5.89	5.99	0.228	0.232	0.236
E2	3.48	3.66	3.84	0.137	0.144	0.151
E3	3.68	3.78	3.91	0.145	0.149	0.154
E4	0.75 TYP.			0.030 TYP.		
е	1.27 BSC				0.050 BSC	
K		1.27 TYP.			0.050 TYP.	
K1	0.56	-	-	0.022	=	-
Н	0.51	0.61	0.71	0.020	0.024	0.028
L	0.51	0.61	0.71	0.020	0.024	0.028
L1	0.06	0.13	0.20	0.002	0.005	0.008
θ	0°	-	12°	0°	-	12°
W	0.15	0.25	0.36	0.006	0.010	0.014
М		0.125 TYP.	•		0.005 TYP.	

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DWG: 5881





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